UNISONIC TECHNOLOGIES CO., LTD

4N55-HC **Power MOSFET**

4A, 550V N-CHANNEL **POWER MOSFET**

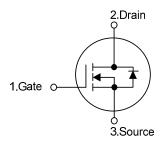
DESCRIPTION

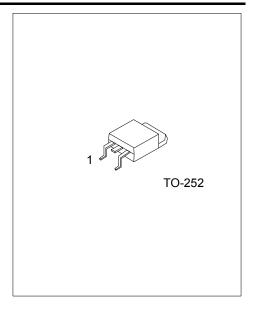
The UTC 4N55-HC is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

FEATURES

- * $R_{DS(ON)}$ < 2.5 Ω @ V_{GS} = 10V, I_D = 2.0A
- * Fast switching capability
- * Avalanche energy tested
- * Improved dv/dt capability, high ruggedness

SYMBOL

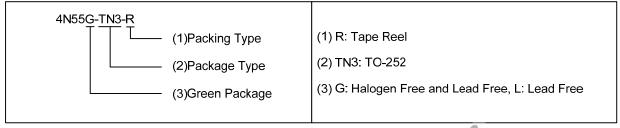




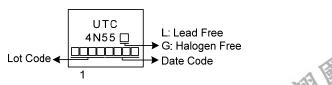
ORDERING INFORMATION

Ordering Number		Dealtage	Pin	Assignm	Dooking		
Lead Free	Halogen Free	Package	1	2	3	Packing	
4N55L-TN3-R	4N55G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



MARKING



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■ ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Drain-Source Voltage	V_{DSS}	550	V
Gate-Source Voltage	V _{GSS}	±30	V
Continuous Drain Current	I _D	4	Α
Pulsed Drain Current (Note 2)	I _{DM}	8	Α
Avalanche Energy Single Pulsed (Note 3)	E _{AS}	156	mJ
Peak Diode Recovery dv/dt (Note 4)	dv/dt	3	V/ns
Power Dissipation	P_D	52	W
Junction Temperature	T_J	+150	°C
Storage Temperature	T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 10mH, I_{AS} = 5.6A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25°C
- 4. $I_{SD} \le 4.0A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	110	°C/W	
Junction to Case	$\theta_{ m JC}$	2.5 (Note)	°C/W	

Note: The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

■ ELECTRICAL CHARACTERISTICS (T_J=25°C, unless otherwise specified)

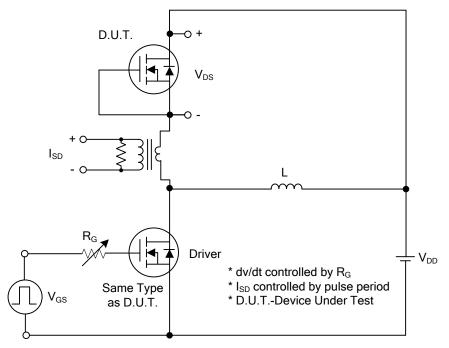
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV _{DSS}	$V_{GS} = 0V, I_D = 250\mu A$	550			V	
Drain-Source Leakage Current		I _{DSS}	$V_{DS} = 550V, V_{GS} = 0V$			10	μΑ	
Gate- Source Leakage Current	Forward	1	$V_{GS} = 30V, V_{DS} = 0V$			100	nA	
	Reverse	I _{GSS}	$V_{GS} = -30V, V_{DS} = 0V$			-100	nA	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	2.0		4.0	V	
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} = 10V, I _D = 2.0A			2.5	Ω	
DYNAMIC CHARACTERISTICS								
Input Capacitance		C _{ISS}			337		pF	
Output Capacitance		Coss	V _{DS} =25V, V _{GS} =0V, f=1.0 MHz		54.5		pF	
Reverse Transfer Capacitance		C _{RSS}			10.5		pF	
SWITCHING CHARACTERISTICS								
Total Gate Charge (Note 1)		Q_G	V _{DS} =100V, V _{GS} =10V, I _D =4.0A,		12		nC	
Gate-Source Charge		Q_GS	I _D =1mA (Note 1, 2)		5.24		nC	
Gate-Drain Charge		Q_GD	ID-IIIA (Note 1, 2)		3.5		nC	
Turn-On Delay Time (Note 1)		t _{D(ON)}	V_{DD} =100V, V_{GS} =10V, I_{D} =4.0A, R_{G} =25 Ω (Note 1, 2)		7.2		ns	
Turn-On Rise Time		t _R			19		ns	
Turn-Off Delay Time		t _{D(OFF)}			41.5		ns	
Turn-Off Fall Time		t _F			27		ns	
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS								
Maximum Body-Diode Continuous Current		Is	SE CO	1,,		4	Α	
Maximum Body-Diode Pulsed Current		I _{SM}	4 18 (28.			8	Α	
Drain-Source Diode Forward Voltage		V_{SD}	I _S =4.0A, V _{GS} =0V			1.4	V	
Body Diode Reverse Recovery Time		t _{rr}	l _S =4.0A , V _{GS} =0V di/dt=100A/μs		268		ns	
Body Diode Reverse Recovery Charge		Qm	is-4.0A, ves-0v di/dt=100A/µs		1.5		μC	

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

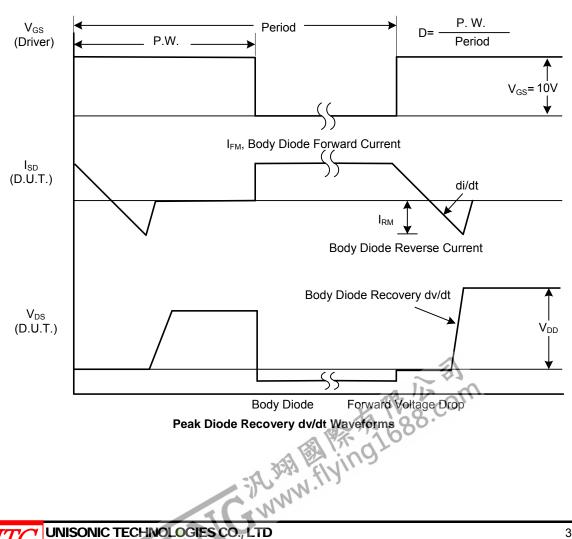
2. Essentially independent of operating temperature.



TEST CIRCUITS AND WAVEFORMS

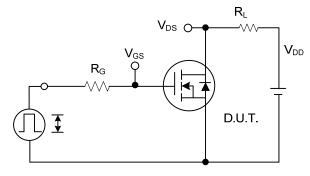


Peak Diode Recovery dv/dt Test Circuit

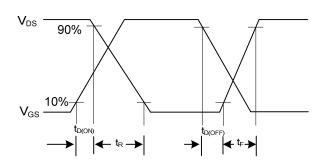


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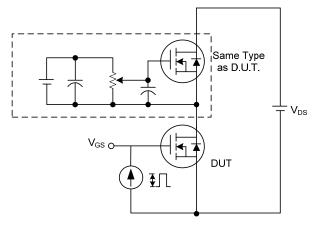
TEST CIRCUITS AND WAVEFORMS



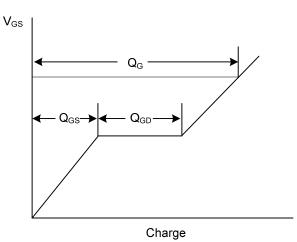
Switching Test Circuit



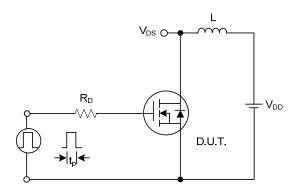
Switching Waveforms



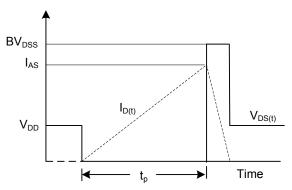
Gate Charge Test Circuit



Gate Charge Waveform

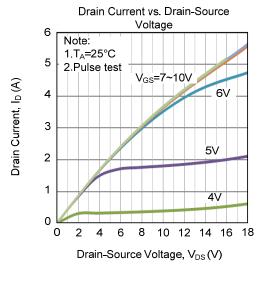


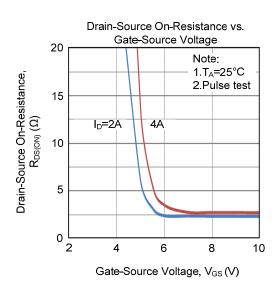
Unclamped Inductive Switching Test Circuit

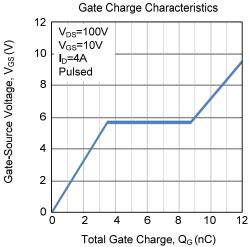


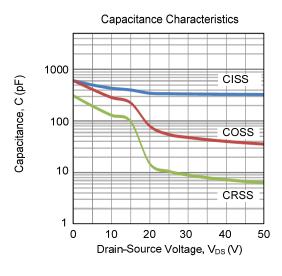
Unclamped Inductive Switching Waveforms

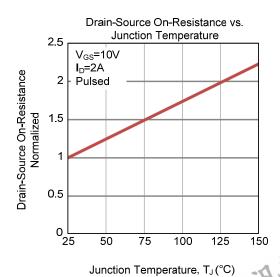
■ TYPICAL CHARACTERISTICS

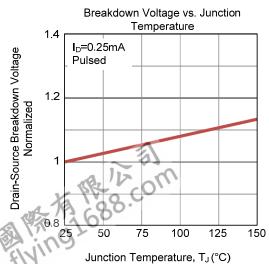




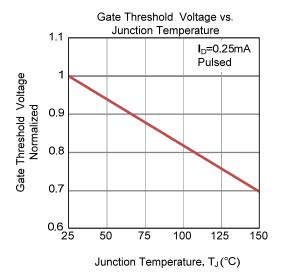


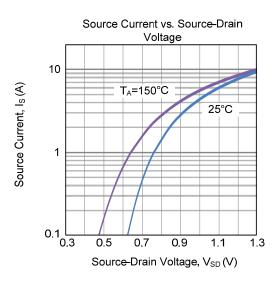


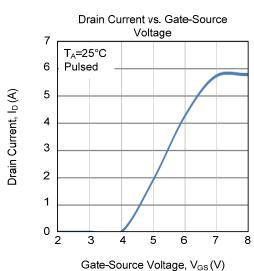


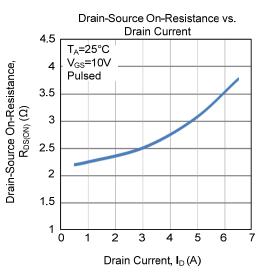


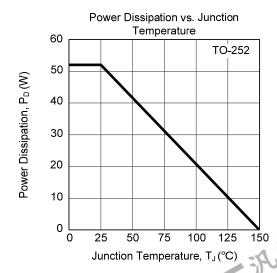
■ TYPICAL CHARACTERISTICS (Cont.)

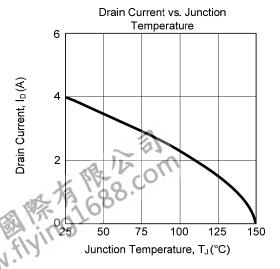




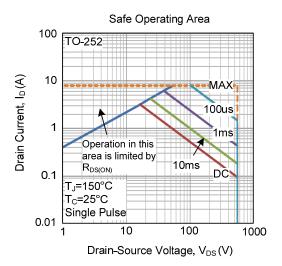








■ TYPICAL CHARACTERISTICS (Cont.)



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